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Kind regards,

Team Nexperia

1. General description

Logic level N-channel MOSFET in D2PAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

2. Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for logic level gate drive sources

3. Applications

- DC-to-DC converters
- Load switiching
- Motor control
- Server power supplies

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	30	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; <u>Fig. 2</u>	[1]	-	-	120	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	306	W
Tj	junction temperature			-55	-	175	°C
Static charact	eristics						-
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; Fig. 12		-	0.89	1	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 100 °C; Fig. 13; Fig. 12		-	1.19	1.5	mΩ
Dynamic char	acteristics						
Q_{GD}	gate-drain charge	V_{GS} = 4.5 V; I_D = 75 A; V_{DS} = 15 V;		-	37	-	nC
Q _{G(tot)}	total gate charge	Fig. 14; Fig. 15		-	118	-	nC





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N-channel 30 V 1.0 m Ω logic level MOSFET in D2PAK

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Avalanche ruggedness							
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 120 A; $V_{sup} \le$ 30 V; R_{GS} = 50 Ω; unclamped		-	-	1.9	J

[1] Continuous current is limited by package.

Pinning information

Table 2. **Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D I
2	D	drain[1]		
3	S	source		G (F) (A)
mb	D	mounting base; connected to drain	D2PAK (SOT404)	mbb076 S

[1] It is not possible to make connection to pin 2

Ordering information

Table 3. **Ordering information**

Type number	Package					
	Name	Description	Version			
PSMNR90-30BL	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404			

Marking

Table 4. **Marking codes**

Type number	Marking code
PSMNR90-30BL	PSMNR90-30BL

Limiting values 8.

Limiting values

PSMNR90-30BL

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	30	V
V_{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	30	V

N-channel 30 V 1.0 m Ω logic level MOSFET in D2PAK

Symbol	Parameter	Conditions		Min	Max	Unit
V_{GS}	gate-source voltage			-20	20	V
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	306	W
I _D	drain current	V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>	[1]	-	120	Α
		V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	120	Α
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 °C$; Fig. 3		-	1573	Α
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
T _{sld(M)}	peak soldering temperature			-	260	°C
Source-drain	n diode					
Is	source current	T _{mb} = 25 °C	[1]	-	120	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	1573	Α
Avalanche r	uggedness	,	'	'	'	
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_{D} = 120 A; $V_{sup} \le$ 30 V; R_{GS} = 50 Ω; unclamped		-	1.9	J

[1] Continuous current is limited by package.

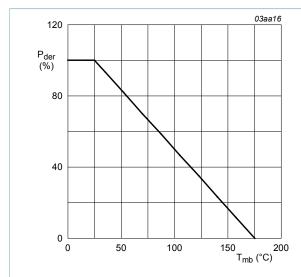


Fig. 1. Normalized total power dissipation as a function of mounting base temperature

$$P_{\textit{der}} = \frac{P_{\textit{tot}}}{P_{\textit{tot}(25^{\circ}\textit{C})}} \times \textbf{100 \%}$$

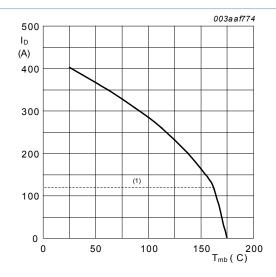


Fig. 2. Continuous drain current as a function of mounting base temperature.

 $V_{\it GS} \ge 10~{
m V};~~(1)~{
m Capped}$ at 120 A due to package

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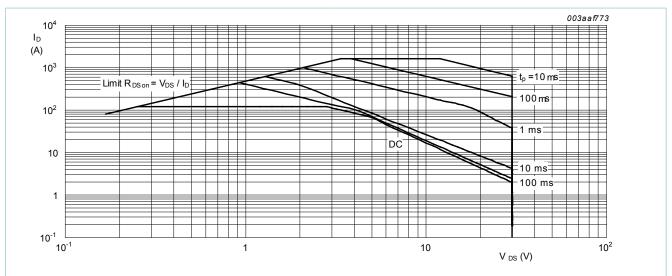


Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

 T_{mb} = 25 °C; I_{DM} is a single pulse; Capped at 120 A due to package

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. 4	-	0.22	0.49	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	50	-	K/W

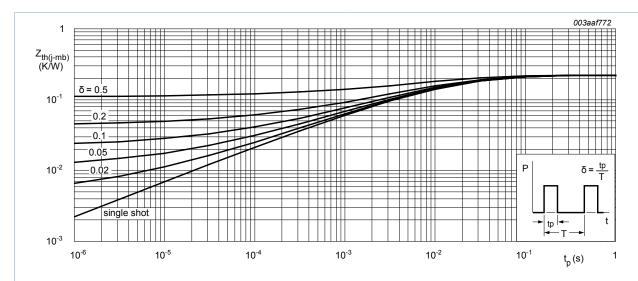


Fig. 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

PSMNR90-30BL

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N-channel 30 V 1.0 m Ω logic level MOSFET in D2PAK

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics		,			
V _{(BR)DSS} drain-source		$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
	breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	27	-	-	٧
$V_{GS(th)}$	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C; Fig. 10; Fig. 11	1.3	1.7	2.2	V
		I_D = 1 mA; V_{DS} = V_{GS} ; T_j = 175 °C; Fig. 11	0.65	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ Fig. 11	-	-	2.5	V
I _{DSS}	drain leakage current	V _{DS} = 30 V; V _{GS} = 0 V; T _j = 25 °C	-	0.02	10	μΑ
		V _{DS} = 30 V; V _{GS} = 0 V; T _j = 175 °C	-	-	500	μΑ
I _{GSS} gate leakage curren	gate leakage current	V _{GS} = 16 V; V _{DS} = 0 V; T _j = 25 °C	-	10	100	nA
		V _{GS} = -16 V; V _{DS} = 0 V; T _j = 25 °C	-	10	100	nA
200	drain-source on-state resistance	V_{GS} = 10 V; I_D = 25 A; T_j = 25 °C; Fig. 12	-	0.89	1	mΩ
		V_{GS} = 4.5 V; I_D = 25 A; T_j = 25 °C; Fig. 12	-	1.1	1.4	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 175 °C; Fig. 13; Fig. 12	-	1.65	2	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 100 °C; Fig. 13; Fig. 12	-	1.19	1.5	mΩ
R _G	gate resistance	f = 1 MHz	-	1.1	-	Ω
Dynamic o	characteristics		l			
Q _{G(tot)}	total gate charge	I _D = 75 A; V _{DS} = 15 V; V _{GS} = 10 V; Fig. 14; Fig. 15	-	243	-	nC
		I _D = 0 A; V _{DS} = 0 V; V _{GS} = 10 V	-	222	-	nC
		I _D = 75 A; V _{DS} = 15 V; V _{GS} = 4.5 V;	-	118	-	nC
Q_{GS}	gate-source charge	Fig. 14; Fig. 15	-	39	-	nC
Q _{GS(th)}	pre-threshold gate- source charge		-	22	-	nC
Q _{GS(th-pl)}	post-threshold gate- source charge		-	17	-	nC
Q_{GD}	gate-drain charge		-	37	-	nC
V _{GS(pl)}	gate-source plateau voltage	I _D = 75 A; V _{DS} = 15 V; <u>Fig. 14</u> ; <u>Fig. 15</u>	-	2.8	-	V

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Symbol	Parameter	Conditions	N	V lin	Тур	Max	Unit
C _{iss}	input capacitance	$V_{DS} = 15 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	-	14850	-	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 16</u>	-	-	2799	-	pF
C _{rss}	reverse transfer capacitance			-	1215	-	pF
$t_{d(on)}$	turn-on delay time	V_{DS} = 15 V; R_L = 0.2 Ω ; V_{GS} = 5 V; $R_{G(ext)}$ = 5 Ω ; I_D = 75 A; T_j = 25 °C	-	-	95	-	ns
t _r	rise time	V_{DS} = 15 V; R_L = 0.2 Ω ; V_{GS} = 5 V; $R_{G(ext)}$ = 5 Ω ; T_j = 25 °C; I_D = 75 A	-	-	213	-	ns
t _{d(off)}	turn-off delay time	V_{DS} = 15 V; R_L = 0.2 Ω ; V_{GS} = 5 V;	-	-	199	-	ns
t _f	fall time	$R_{G(ext)} = 5 \Omega$; $I_D = 75 A$; $T_j = 25 °C$	-	-	115	-	ns
Source-dra	in diode					1	
V _{SD}	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}; Fig. 17$	-	-	0.8	1.2	V
t _{rr}	reverse recovery time	$I_S = 25 \text{ A}; dI_S/dt = -100 \text{ A/}\mu\text{s}; V_{GS} = 0 \text{ V};$	-	-	67	-	ns
Q _r	recovered charge	V _{DS} = 15 V	-	-	123	-	nC

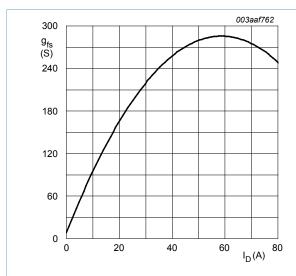


Fig. 5. Forward transconductance as a function of drain current; typical values

$$T_j=25\,^{\circ}C; V_{DS}=15\,V$$

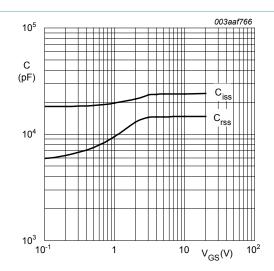


Fig. 6. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

$$V_{DS} = 0V; f = 1MHz$$

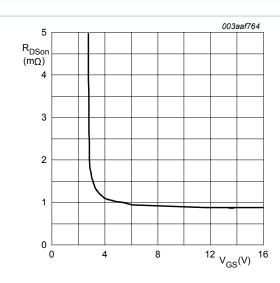


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

$$T_j = 25 \,^{\circ}C; I_D = 25 \,^{\circ}A$$

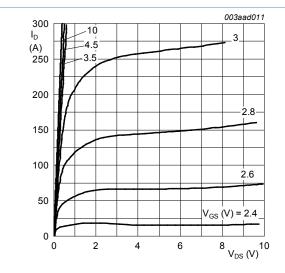


Fig. 9. Output characteristics: drain current as a function of drain-source voltage; typical values

$$T_j = 25 \,^{\circ}C$$

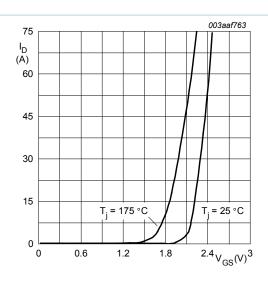


Fig. 8. Transfer characteristics: drain current as a function of gate-source voltage; typical values

$$V_{DS} > I_D \times R_{DSon}$$

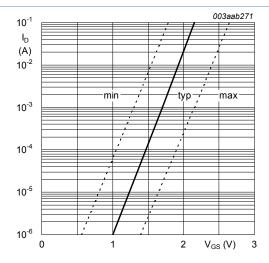


Fig. 10. Sub-threshold drain current as a function of gate-source voltage

$$T_j=25\,^{\circ}C; V_{DS}=5\,V$$

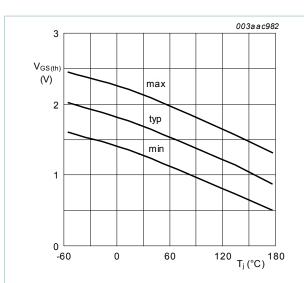
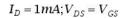


Fig. 11. Gate-source threshold voltage as a function of junction temperature



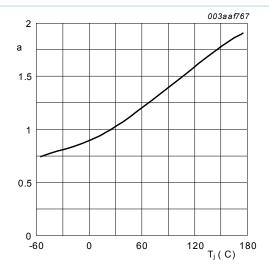


Fig. 13. Normalized drain-source on-state resistance factor as a function of junction temperature

$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

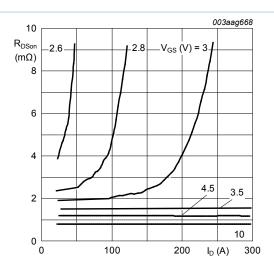


Fig. 12. Drain-source on-state resistance as a function of drain current; typical values

$$T_j = 25 \,^{\circ}C$$

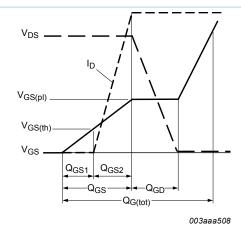


Fig. 14. Gate charge waveform definitions

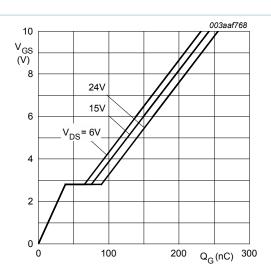


Fig. 15. Gate-source voltage as a function of gate charge; typical values

$$T_j = 25$$
 °C; $I_D = 75$ A

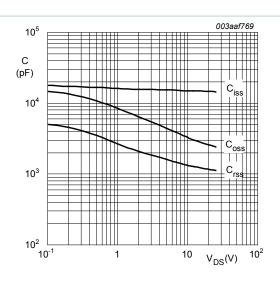


Fig. 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

$$V_{GS} = 0V; f = 1MHz$$

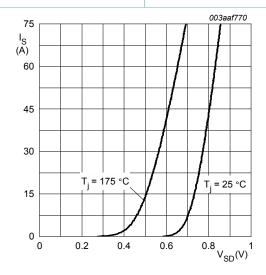
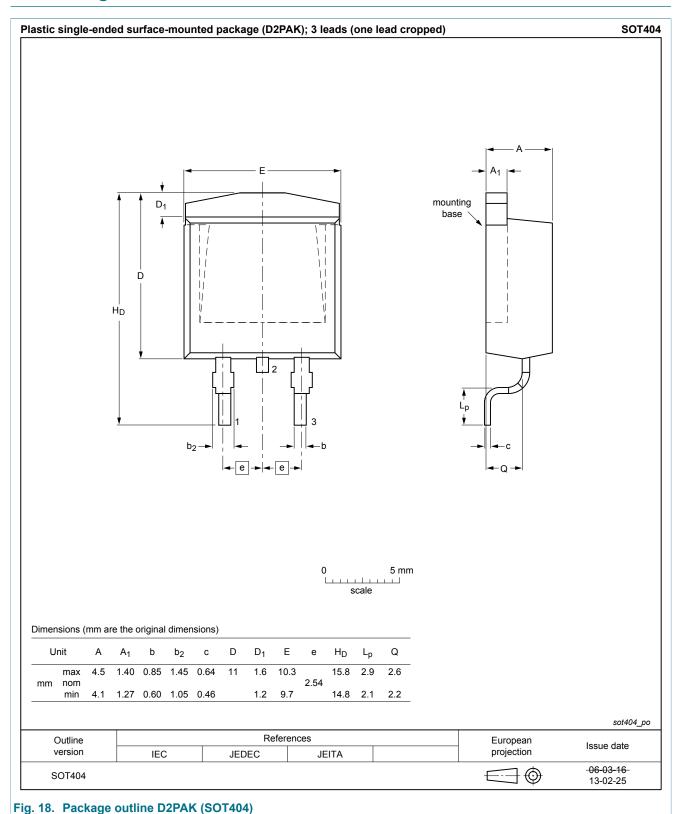


Fig. 17. Source current as a function of source-drain voltage; typical values

$$V_{GS} = 0 V$$

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11. Package outline



N-channel 30 V 1.0 m Ω logic level MOSFET in D2PAK

12. Legal information

12.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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